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SPECIFICATION FOR LCD MODULE

MODULE NO: AFV240320A01-2.8N6NTN REVISION NO: 01

Customer's Approval:						
	SIGNATURE	DATE				
PREPARED BY (RD ENGINEER)						
CHECKED BY						
APPROVED BY						

REVISION RECORD

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■ GENERAL INFORMATION

AFV240320A01-2.8N6NTN

Item	Contents	Unit
LCD size	2.8 inch (Digital)	1
LCD type	TFT/TRANSMISSIVE normal white	
View direction	6 o'clock (Gray scale inversion- 12 o'clock)	
Resolution	240*3(RGB)*320	
Module size (W × H×T)	50.0(W)×69.2(H)×2.45(D)	mm
Active area (W×H)	43.2(H)×57.6(V)	mm
Pixel pitch (W × H)		mm
Interface Type	8080 16bit interface	/
Input voltage	2.8V	V
Module Power consumption	TBD	mw
Backlight Type	4*LED	1

ABSOLUTE MAXIMUM RATINGS

Item	Symbol	Min.	Max.	Unit	Condition
Supply voltage	VCC	-0.3vcc	4.8	V	
Logic voltage	lovcc	-0.3vcc	3.3	V	
Input Current	ldd	-	lovcc+0.3	mA	
Operating temperature	VIH	-20	70	$^{\circ}$	
Storage temperature	VIL	-30	80	$^{\circ}$	
Humidity	VOH	-	90%(5 5℃)	Dot	

ELECTRICAL CHARACTERISTICS

DC CHARACTERISTICS

Item	Symbol	Min.	Тур.	Max.	Unit	Condition
Supply voltage	VCC	2.3	2.8	3.6	V	
Logic voltage	lovcc	1.65	2.8	3.3	V	
Current for LED backlight	ldd	-	110		mA	
Input voltage H level	VIH	0.8lovcc	-	lovcc	V	
Input voltage L level	VIL	0	-	0.2lovcc	V	
Output voltage H level	VOH	0.8lovcc	-	lovcc	V	
Output voltage L level	VOL	0	-	0.2lovcc	V	

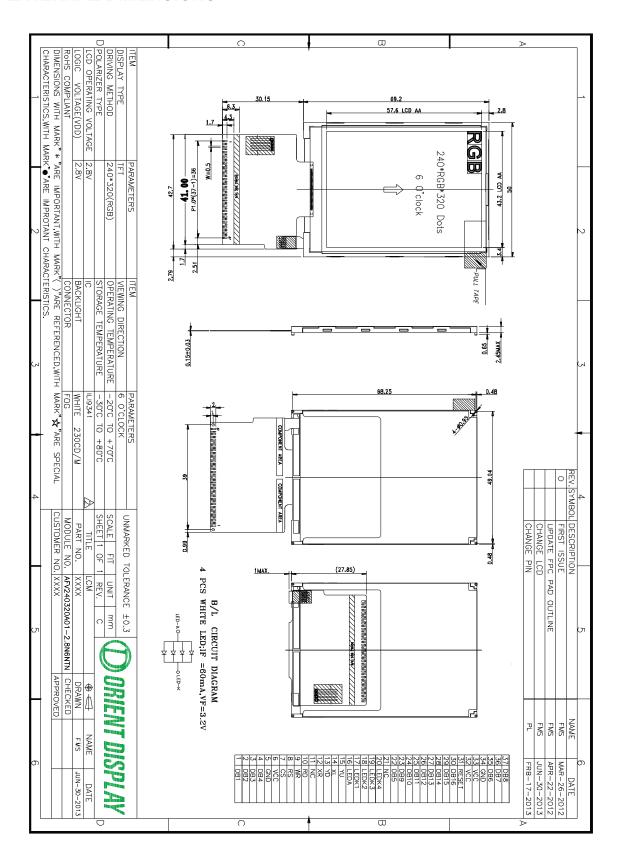
■ BACKLIGHT CHARACTERISTICS

Item	Symbol	Min.	Тур.	Max.	Unit	Condition
Forward voltage	Vf	-	3.2	3.3	V	Note 1
Current for LED backlight	IL	-	80	84	mA	Note 1
LED life time		20,000	-	-	Hour	Note 2

Note 1: The LED Supply Voltage is defined by the number of LED at Ta=25°C and IL =20mA for each LED.

Note 2: The "LED life time" is defined as the module brightness decrease to 50% original brightness at Ta=25°C and IL =20mA. The LED lifetime could be decreased if operating IL is larger than 20 mA.

EXTERNAL DIMENSIONS



■ ELECTRO-OPTICAL CHARACTERISTICS

Item	Symbol	Condition	Min	Тур	Max	Unit	Remar k	Note
Response time	Tr+ Tf		_	10	20	ms	FIG.1	4
Contrast ratio	Cr		250	300	_		FIG 2.	1
Luminance uniformity	δ WHITE		-	-	_	%	FIG 2.	3
Surface Luminance	Lv	AVD-TT70WV-NN -002-A	210	230	_	cd/m	FIG 2.	2
		Ø = 90°	30	50	_	deg	FIG 3.	
Viewing angle	θ	Ø = 270°	35	60	_	deg	FIG 3.	6
range	0	Ø = 0°	35	60	_	deg	FIG 3.	0
		Ø = 180°	35	60	_	deg	FIG 3.	
	Red x		_	0.609	_	-		
	Red y		_	0.332	_	-		
	Green x	θ=0°	_	0.300	_	-		
CIE (x, y)	Green y	∅=0°	_	0.567	_	-	FIG 2.	5
chromaticity	Blue x	7	_	0.143	_	-	- FIG 2. 5	
	Blue y	_ Ta=25 C	_	0.114	_	-		
	White x		_	0.304	_	-		
	White y		_	0.339	_	-		

- **Note1.** Contrast Ratio(CR) is defined mathematically by the following formula. For more information see FIG 2.:
 - Contrast Ratio = Average Surface Luminance with all white pixels (P 1,P2, P 3,P4, P5)

 Average Surface Luminance with all black pixels (P1, P2, P 3,P4, P5)
- **Note2.** Surface luminance is the LCD surface from the surface with all pixels displaying white. For more information see FIG 2.
 - Lv = Average Surface Luminance with all white pixels (P1, P2, P3,P4, P5)
- Note3. The uniformity in surface luminance (δWHITE) is determined by measuring luminance at each test position 1 through 5, and then dividing the maximum luminance of 5 points luminance by minimum luminance of 5 points luminance. For more information see FIG 2.
 - δ WHITE = Minimum Surface Luminance with all white pixels (P₁, P₂, P₃,P₄, P₅)

 Maximum Surface Luminance with all white pixels (P₁, P₂, P₃,P₄, P₅)
- Note4. Response time is the time required for the display to transition from White to black(Rise Time, Tr) and from black to white(Decay Time, Tf). For additional information see FIG 1..
- **Note5.** CIE (x, y) chromaticity ,The x,y value is determined by screen active area position NO.5 For more information see FIG 2.
- Note6. Viewing angle is the angle at which the contrast ratio is greater than 2. For TFT module the conrast ratio is greater than 10. The angles are determined for the horizontal or x axis and the vertical or y axis with respect to the z axis which is normal to the LCD surface. For more information see FIG 3.
- **Note7.** For Viewing angle and response time testing, the testing data is base on Autronic-Melchers's ConoScope. Series Instruments. For contrast ratio, Surface Luminance, Luminance uniformity and CIE, the testing data is base on TOPCON's BM-5 photo detector or compatible.
- **Note8.** For TFT module, Gray scale reverse occurs in the direction of panel viewing angle

FIG.1. The definition of Response Time

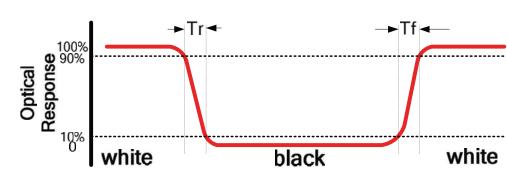


FIG.2. Measuring method for Contrast ratio, surface luminance, Luminance uniformity, CIE (x, y) chromaticity

A : 5 mm B : 5 mm

H.V: Active Area

Light spot size \varnothing =5mm, 500mm distance from

the LCD surface to detector lens

measurement instrument is TOPCON's

luminance meter BM-7

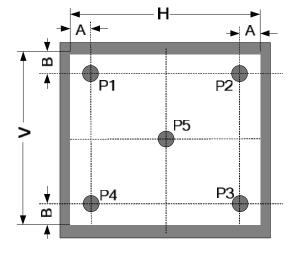
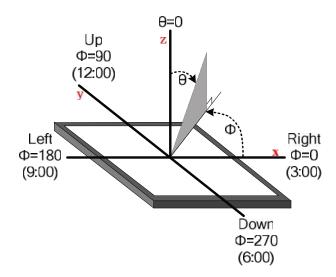


FIG.3. The definition of viewing angle



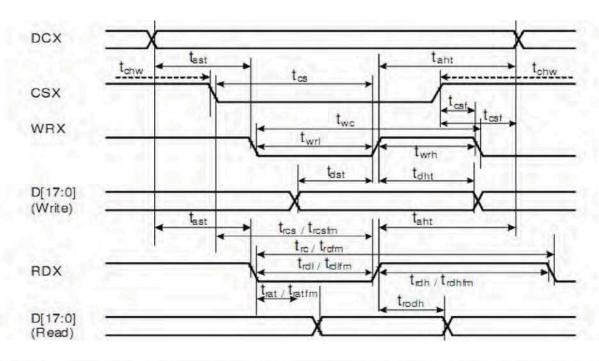
■ INTERFACE DESCRIPTION

Interface NO.	NAME	I/O or connect to	DESCRIPTION
1-4	DB1-DB4	1	Data bus
5	GND	Р	Power ground
6	VCC	Р	Power supply(TYP=2.8V)
7	CS	I	Chip selection pin
8	RS	I	A Register select signal
9	WR	I	Write strobe signal
10	RD	I	Read strobe signal
11	NC	I	Not connect
12	XR(NC)	I	TP signal
13	YD(NC)	I	TP signal
14	XL(NC)	I	TP signal
15	YU(NC)	I	TP signal
16	VLED+	Р	Power for LED backlight(Anode)
17-20	VLED-	Р	Power for LED backlight(Cathode)
21	NC		Not connect
22	DB5	1	Data bus
23-30	DB9-DB16	I	Data bus
31	RESET	I	Reset signal; suggest connect with RC circuit; low active
32	VCC	Р	Power supply (TYP=2.8V)
33	vcc	Р	Power supply (TYP=2.8V)
34	GND	Р	Power ground
35-37	DB6-DB8	I	Data bus

■ TIMING CHARACTERISTICS

8080-system bus interface operation

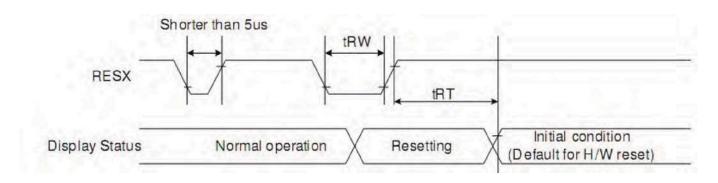
Ta = -20 °C to +70 °C, VCC = 2.80V, GND=0V.



Signal	Symbol	Parameter	min	max	Unit	Description	
DCX	tast	Address setup time	0		ns	No.	
DCX that		Address hold time (Write/Read)	10		ns		
	tonw	CSX "H" pulse width	0		ns		
	tos	Chip Select setup time (Write)	15		ns		
CSX	tros	Chip Select setup time (Read ID)	45	10.	ns		
	trostm	Chip Select setup time (Read FM)	355		ns		
	tost	Chip Select Wait time (Write/Read)	10	-	ns		
	twe	Write cycle	66		ns		
WRX	t _{wrh}	Write Control pulse H duration	33		ns		
100 -	twri	Write Control pulse L duration	33		ns		
	tro	Read cycle (ID)	160	-	ns		
RDX (ID)	tran	Read Control pulse H duration	90		ns	When read ID data	
	trd	Read Control pulse L duration	45		ns	The second second second	
	trofm	Read Cycle (FM)	450	-	ns	When read from the fram	
RDX (FM)	teintm	Read Control H duration (FM)	90		ns	Charles of the Control of the Contro	
	traitm	Read Control L duration (FM)	355	-	ns	memory	
DD[17:0]	t _{dst}	Write data setup time	10		ns	The second second	
DB[17:0], DB[15:0],	tant	Write data hold time	10		ns	For maximum CL=30pF	
	trat	Read access time		40	ns	For minimum CL=30pF	
DB[8:0], DB[7:0]	testm	Read access time		340	ns	I of millimant CL=opr	
[0.1]	trod	Read output disable time	20	80	ns		

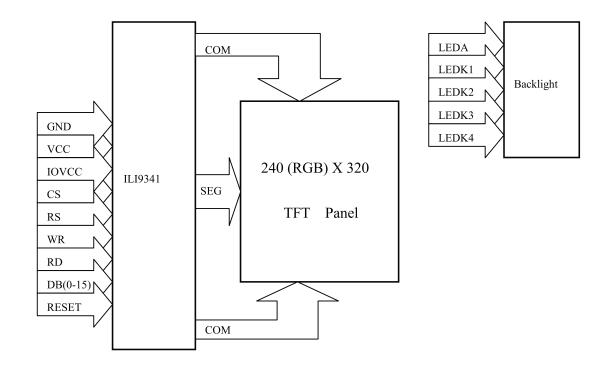
Note: Ta = -40 to 85 ℃, IOVCC=1.65V to 3.3V, VCI=2.3V to 4.8V, DGND=0V

Resetting



Signal	Symbol	Parameter	Min	Max	Unit
RESX	tRW	Reset pulse duration	10		uS
tRT		Poset especi		5 (note 1,5)	mS
		Reset cancel		120 (note 1,6,7)	mS

■ REFERENCE APPLICATION CIRCUIT



■ RELIABILITY TEST CONDITIONS

No.	Test Item	Test Condition	Inspection after test
1	High Temperature Storage	80±2°C/240 hours	
2	Low Temperature Storage	-30±2℃/240 hours	
3	High Temperature Operating	70±2°C/120 hours	
4	Low Temperature Operating	-20±2℃/120 hours	Inspection after 2~4hours
5	Temperature Cycle	-20±2°C~25~70±2°C×10cycles	storage at room
		(30min.) (5min.) (30min.)	temperature, the sample
6	Damp Proof Test	50℃±5℃×90%RH/120 hours	shall be free from defects:
7	Vibration Test	Frequency: 10Hz~55Hz~10Hz Amplitude: 1.5mm, X, Y, Z direction for total 3hours (Packing condition)	1.Air bubble in the LCD; 2.Sealleak; 3.Non-display; 4.missing segments;
8	Dropping test	Drop to the ground from 1m height, one time, every side of carton. (Packing condition)	5.Glass crack; 6.Current ldd is twice higher than initial value.
9	ESD test	Voltage:±8KV R: 330Ω C: 150pF Air discharge, 10time	

Remark:

- 1. The test samples should be applied to only one test item.
- 2. Sample size for each test item is 5~10pcs.
- **3**. For Damp Proof Test, Pure water(Resistance>10M Ω) should be used.
- **4**. In case of malfunction defect caused by ESD damage, if it would be recovered to normal state after resetting, it would be judged as a good part.
- **5**. EL evaluation should be excepted from reliability test with humidity and temperature: Some defects such as black spot/blemish can happen by natural chemical reaction with humidity and Fluorescence EL has.
- **6**. Failure Judgment Criterion: Basic Specification, Electrical Characteristic, Mechanical Characteristic, Optical Characteristic.

■ INSPECTION CRITERION

This specification is made to be used as the standard acceptance/rejection criteria for Normal LCM Product.

1 Sample plan

Sampling plan according to GB/T2828.1-2004/ISO 2859-1: 1999 and ANSI/ASQC Z1.4-1993, normal level 2 and based on:

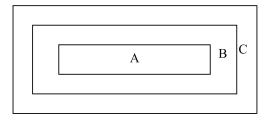
Major defect: AQL 0.65 Minor defect: AQL 1.5

2. Inspection condition

- Viewing distance for cosmetic inspection is about 30cm with bare eyes, and under an environment of 20~40W light intensity, all directions for inspecting the sample should be within 45°against perpendicular line. (Normal temperature 20~25°C and normal humidity 60±15%RH).
- Driving voltage

 The Vop value from which the most optimal contrast can be obtained near the specified Vop in the specification (Within ±0.5V of the typical value at 25°C.).

3. Definition of inspection zone in LCD.



Zone A: character/Digit area

Zone B: viewing area except Zone A (ZoneA+ZoneB=minimum Viewing area)

Zone C: Outside viewing area (invisible area after assembly in customer's product)

Fig.1 Inspection zones in an LCD.

Note: As a general rule, visual defects in Zone C are permissible, when it is no trouble for quality and assembly of customer's product.

4.Inspection Standard

4.1 Major Defect

Item	Items to be inspected	Inspection Standard	Classification of defects
4.1.1	All functional defects	 No display Display abnormally Missing vertical, horizontal segment Short circuit Back-light no lighting, flickering and abnormal lighting. 	
4.1.2	Missing	Missing component	Major
4.1.3	Outline dimension	Overall outline dimension beyond the drawing is not allowed.	

4.2 Cosmetic Defect

4.2.1 Module Cosmetic Criteria

No.	Item	Judgement Criterion	Partition
1	Difference in Spec.	None allowed	Major
2	Pattern peeling	No substrate pattern peeling and floating	Major
3	Soldering defects	No soldering missing	Major
		No soldering bridge	Major
		No cold soldering	Minor
4	Resist flaw on Printed Circuit Boards	visible copper foil (∅0.5mm or more) on substrate pattern	Minor
5	Accretion of metallic	No accretion of metallic foreign matters (Not exceed	Minor
	Foreign matter	Ø0.2mm)	Minor
6	Stain	No stain to spoil cosmetic badly	Minor
7	Plate discoloring	No plate fading, rusting and discoloring	Minor
8	Solder amount 1. Lead parts	a. Soldering side of PCB Solder to form a 'Filet' all around the lead. Solder should not hide the lead form perfectly. (too much) b. Components side (In case of 'Through Hole PCB') Solder to reach the Components side of PCB.	Minor
	2. Flat packages	Either 'Toe' (A) or 'Seal' (B) of the lead to be covered by 'Filet'. Lead form to be assume over solder.	Minor
	3. Chips	(3/2) $H \ge h \ge$ (1/2) H	Minor

9	Solder ball/Solder splash	 a. The spacing between solder ball and the conductor or solder pad h ≥0.13n The diameter of solder ball d ≤0.15mm d b. The quantity of solder balls or solder Splashes isn't beyond 5 in 600 mm². c.Solder balls/Solder splashes do not violate minimum electrical clearance. d. Solder balls/Solder splashes must be entrapped/encapsulated Or attached to the metal surface. NOTE: Entrapped/encapsulated/attached is intended to mean that normal service environment of the product will not cause a solder ball to become dislogged 	Minor Minor Major Minor
		a solder ball to become dislodged.	

4.2.2Cosmetic Criteria (Non-Operating)

No.	Defect	Juc	Partition			
1	Spots	In accordance with Screen	Minor			
2	Lines	In accordance with Screen	Cosmetic Criteria (Operating) No.2.	Minor		
3	Bubbles in			Minor		
	polarizer	Size : d mm	Acceptable Qty in active area			
		d ≤ 0.3	Disregard			
		$0.3 < d \le 1.0$	3			
		1.0 < d ≤ 1.5	1			
		1.5 < d	0			
4	Scratch	In accordance with spots and lines operating cosmetic criteria. When				
		the light reflects on the panel surface, the scratches are not to be				
		remarkable.				
5	Allowable density	Above defects should be separated more than 30mm each other.				
6	Coloration	Not to be noticeable coloration in the viewing area of the LCD				
		panels.				
		Back-lit type should be judged with back-lit on state only.				
7	Contamination	Not to be noticeable.				

4.2.3 Cosmetic Criteria (Operating)

No.	Defect	Judgment Criterion			Partition
1	Spots	A) Clear			Minor
		Lcd size	Size : mm	Acceptable Qty in active	
			d	area	
			d≤0.1	Disregard	
		Lcd	0.1 <d≤0.2< td=""><td>6</td><td></td></d≤0.2<>	6	
		size≤8.0'	0.2 <d≤0.3< td=""><td>2</td><td></td></d≤0.3<>	2	
			0.3 < d	0	
			d ≤0.1	Disregard	
		Lcd size>8.0'	0.1 <d≤0.3< td=""><td>10</td><td></td></d≤0.3<>	10	
			0.3 <d≤0.5< td=""><td>5</td><td></td></d≤0.5<>	5	
			0.5 < d	0	
		one pixel size; To	tal defective po	tive dots which must be within bint shall not exceed 6 pcs now for more than 8 inch LCD.	
		Lcd size	Size : mm	Acceptable Qty in active	
			d	area	
			d≤0.2	Disregard	
		Lcd size≤8.0'	0.2 <d≤0.5< td=""><td>6</td><td></td></d≤0.5<>	6	
		Size≤o.0	0.5 <d≤0.7< td=""><td>2</td><td></td></d≤0.7<>	2	
			0.7 <d< td=""><td>0</td><td></td></d<>	0	
			d≤0.2	Disregard	
			0.2 <d≤0.5< td=""><td>10</td><td></td></d≤0.5<>	10	
		Lcd size >8.0'	0.5 <d≤0.7< td=""><td>3</td><td></td></d≤0.7<>	3	
			0.7 <d≤1.0< td=""><td>1</td><td></td></d≤1.0<>	1	
			1.0< d	0	
		Note: Total defective pinch LCD and 10PCS for		xceed 6 pcs for no more than nch LCD.	8
2	Lines	A) Clear			Minor
		L —			
				G N 1	
		2.0 (6)		See No. 1	
		0.02	0.05 0	0.1 W	
			ole Qty in active		
		L - Length (mm)	-		
		W - Width (mm)			
		∞ - Disregard			
		B) Unclear			
		L ∞	(6)	(0)	
			(~)		
		2.0	0.2	See No. 1 0.5	
		'Clear' = The shade 'Unclear' = The shade a		ot changed by Vop.	

3	Rubbing line	Not to be noticeable.	Minor	
4	Allowable density	Above defects should be separated more than 10mm each other.	Minor	
5	Rainbow	Not to be noticeable.	Minor	
6	Dot size	To be 95% ~ 105% of the dot size (Typ.) in drawing. Partial defects of each dot (ex. pin-hole) should be treated as 'Spot'. (see Screen Cosmetic Criteria (Operating) No.1)		
7	Uneven brightness (only back-lit type module)	Uneven brightness must be BMAX / BMIN ≤ 2 - BMAX : Max. value by measure in 5 points - BMIN : Min. value by measure in 5 points Divide active area into 4 vertically and horizontally. Measure 5 points shown in the following figure.	Minor	

Note:

- (1) Size : d = (long length + short length) / 2
- (2) The limit samples for each item have priority.
- (3) Complex defects are defined item by item, but if the numbers of defects are defined in above table, the total number should not exceed 10.
- (4) In case of 'concentration', even the spots or the lines of 'disregarded' size should not allowed.

Following three situations should be treated as 'concentration'.

- 7 or over defects in circle of Ø5mm.
- 10 or over defects in circle of \varnothing 10mm.
- 20 or over defects in circle of \emptyset 20mm.